

DESCRIPTION

The ICPLM600 and ICPLM601 devices each consists of an infrared emitting diode optically coupled to a high speed integrated photo detector logic gate.

These devices belong to Isocom Compact Range of optocouplers.

FEATURES

- High speed 10Mbit/s
- Half Pitch 1.27mm
- Common Mode Transient Immunity 5kV/µs min. (ICPLM601)
- High AC Isolation Voltage 3750V_{RMS}
- Guaranteed Performance from -40°C to 85°C
- Pb Free and RoHS Compliant
- Safety Approvals Pending

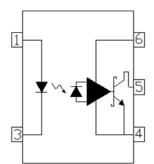
APPLICATIONS

- Line Receivers, Data Communication
- LSTTL to TTL, LSTTL or 5V CMOS
- Data Multiplexing
- Pulse Transformer Replacement
- Switch Mode Power Supplies
- Ground Loop Elimination
- Computer Peripheral Interface

ORDER INFORMATION

 Available in Tape and Reel with 3000pcs per reel.





- l Anode
- 3 Cathode
- 4 GND
- V_0
- $6 V_{CC}$

 V_{CC} must be bypassed by a A 0.1 μ F capacitor.

ABSOLUTE MAXIMUM RATINGS ($T_A = 25$ °C)

Stresses exceeding the absolute maximum ratings can cause permanent damage to the device.

Exposure to absolute maximum ratings for long periods of time can adversely affect reliability.

Input

Forward Current	50mA
Reverse Voltage	5V
Power dissipation	100mW

Output

Output Current	50mA
Output Voltage	7V
Supply Voltage	7V
Power Dissipation	85mW

Total Package

Isolation Voltage	$3750V_{RMS}$
Operating Temperature	-40 to 85 °C
Storage Temperature	-40 to 125 °C
Lead Soldering Temperature	260°C

(10s)

ISOCOM COMPONENTS 2004 LTD

Unit 25B, Park View Road West, Park View Industrial Estate Hartlepool, Cleveland, TS25 1PE, United Kingdom Tel: +44 (0)1429 863 609 Fax: +44 (0)1429 863 581 e-mail: sales@isocom.co.uk

http://www.isocom.com

ISOCOM COMPONENTS ASIA LTD

Hong Kong Office, Block A, 8/F, Wah Hing Industrial mansion, 36 Tai Yau Street, San Po Kong, Kowloon, Hong Kong. Tel: +852 2995 9217 Fax: +852 8161 6292 e-mail: sales@isocom.com.hk



Truth Table (Positive Logic)

Input	Output
Н	L
L	Н

ELECTRICAL CHARACTERISTICS (T_A = -40°C to 85°C unless otherwise specified)

INPUT

Parameter	Symbol	Test Condition	Min	Typ.*	Max	Unit
Forward Voltage	V_{F}	$I_F = 10 \text{mA}$		1.45	1.80	V
Forward Voltage Temperature Coefficient	$\Delta V_{\rm F}/\Delta T$	$I_F = 10 \text{mA}$		-1.9		mV/°C
Reverse Voltage	V_R	$I_R = 10\mu A$	5.0			V
Input Capacitance	C_{IN}	$V_F = 0V$, $f = 1MHz$		70		pF

OUTPUT

Parameter	Symbol	Test Condition	Min	Тур.*	Max	Unit
High Level Supply Current	I_{CCH}	$I_F = 0 \text{mA}, V_{CC} = 5.5 \text{V}$		6.0	9	mA
Low Level Supply Current	I_{CCL}	$I_F = 10 \text{mA}, V_{CC} = 5.5 \text{V}$		7.5	10	mA
High Level Output Current	I_{OH}	$I_F = 250 \mu A, V_{CC} = 5.5 V,$ $V_O = 5.5 V$		2.1	30	μΑ
Low Level Output Voltage	V_{OL}	$I_F = 5mA, V_{CC} = 5.5V,$ $I_{OL} = 13mA$		0.4	0.6	V

COUPLED

Parameter	Symbol	Test Condition	Min	Typ.*	Max	Unit
Input Threshold Current	$ m I_{TH}$	$V_{CC} = 5.5V, V_O = 0.6V$ $I_{OL} = 13mA$		2.4	5	mA

^{*} Typical values at $T_A = 25$ °C



ELECTRICAL CHARACTERISTICS ($T_A = -40$ °C to 85°C unless otherwise specified)

SWITCHING ($T_A = -40$ °C to 85°C, $I_F = 7.5$ mA, $V_{CC} = 5$ V unless otherwise specified)

Parameter	Symbol	Test Condition	Min	Тур.*	Max	Unit
Propagation Delay Time to Logic Low	$\mathrm{T}_{\mathrm{PHL}}$	$R_L = 350\Omega, C_L = 15pF,$ $T_A = 25^{\circ}C$		41	100	ns
Propagation Delay Time to Logic High	T_{PLH}			50	100	
Pulse Width Distortion	t _{PHL} -t _{PLH}	$R_L = 350\Omega, C_L = 15pF$		9	35	
Propagation Delay Skew	t_{PSK}				40]
Output Rise Time	t _r			40]
Output Fall Time	t_{f}			10]
Common Mode Transient Immunity at Logic High	CM _H	$ICPLM600$ $I_F = 0mA, V_{OH} = 2.0V,$ $R_L = 350\Omega,$ $V_{CM} = 10Vp-p,$ $T_A = 25^{\circ}C$		1000		V/μs
		$ICPLM601$ $I_F = 0mA, V_{OH} = 2.0V,$ $R_L = 350\Omega,$ $V_{CM} = 50Vp-p,$ $T_A = 25^{\circ}C$	5000			
Common Mode Transient Immunity at Logic Low	CM_L	$ICPLM600$ $I_F = 7.5 mA, V_{OL} = 0.8 V,$ $R_L = 350 \Omega,$ $V_{CM} = 10 Vp-p,$ $T_A = 25 °C$		1000		
		$ICPLM601$ $I_F = 7.5 mA, \ V_{OL} = 0.8 V,$ $R_L = 350 \Omega,$ $V_{CM} = 50 Vp-p,$ $T_A = 25 ^{\circ}C$	5000			

^{*} Typical values at T_A = 25°C



ELECTRICAL CHARACTERISTICS

Notes:

- 1. The V_{CC} supply must be bypassed by a $0.1\mu F$ capacitor or larger with good high frequency characteristic and should be connected as close as possible to the package V_{CC} and GND pins.
- 2. t_{PLH} Propagation delay is measured from the 3.75mA level on the HIGH to LOW transition of the input current pulse to the 1.5 V level on the LOW to HIGH transition of the output voltage pulse.
- 3. t_{PHL} Propagation delay is measured from the 3.75mA level on the LOW to HIGH transition of the input current pulse to the 1.5 V level on the HIGH to LOW transition of the output voltage pulse.
- 4. t_{PSK} The magnitude of the worst case difference in t_{PHL} and/or t_{PLH} that will be seen between devices at any given temperature within the worst case operating condition range.
- 4 t_r Rise time is measured from the 10% to the 90% levels on the LOW to HIGH transition of the output pulse.
- 5. t_f Fall time is measured from the 90% to the 10% levels on the HIGH to LOW transition of the output pulse.
- 6. CM_H The maximum tolerable rate of rise of the common mode voltage to ensure the output will remain in the HIGH state (i.e., $V_{OUT} > 2.0V$).
- 7. CM_L The maximum tolerable rate of rise of the common mode voltage to ensure the output will remain in the LOW output state (i.e., $V_{OUT} < 0.8V$).



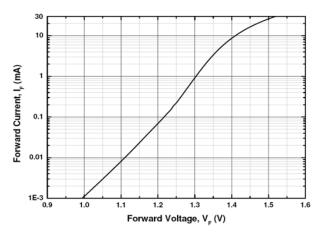


Fig 1 Forward Current vs Forward Voltage

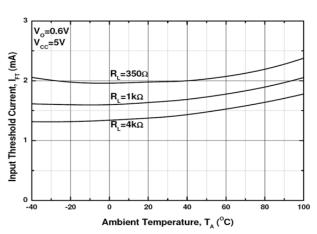


Fig 3 Input Threshold Current vs $T_{\rm A}$

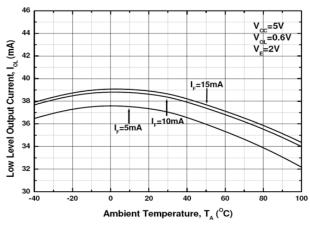


Fig 5 Low Level Output Current vs TA

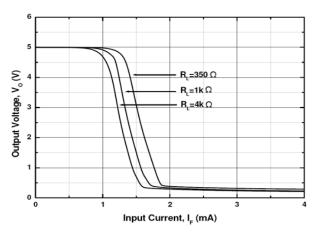


Fig 2 Output Voltage vs Forward Current

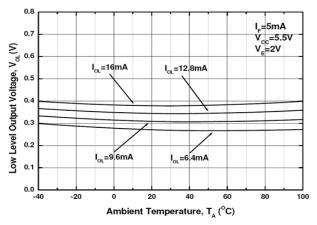


Fig 4 Low Level Output Voltage vs T_A

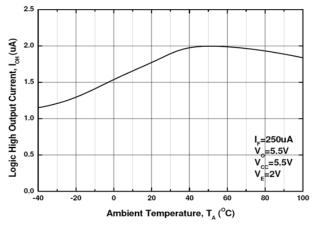


Fig 6 High Level Output Current vs TA



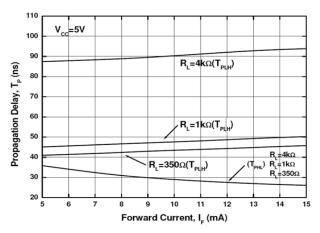


Fig 7 Propagation Delay vs Forward Current

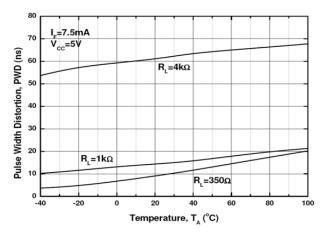


Fig 8 Pulse Width Distortion vs TA

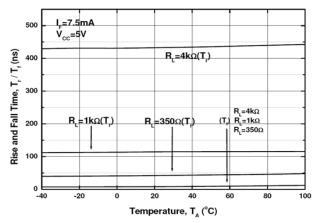
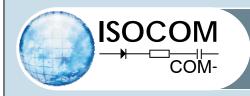
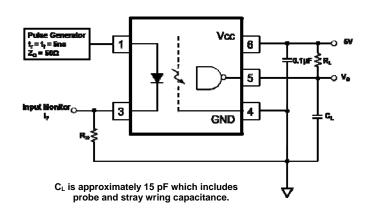
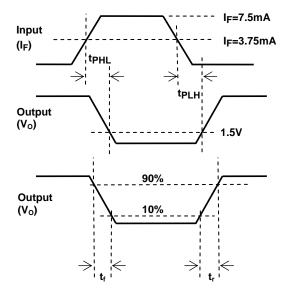


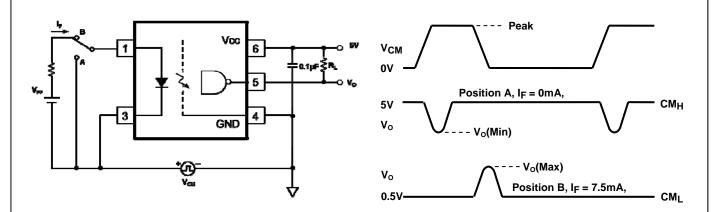
Fig 9 Rise and Fall Time vs T_A







Switching Time Test Circuit



Common Mode Transient Immunity Test Circuit

Common mode transient immunity in logic high level is the maximum tolerable (positive) dV_{CM}/dt on the leading edge of the common mode pulse signal V_{CM} , to assure that the output will remain in a logic high state (i.e., $V_O > 2.0V$).

Common mode transient immunity in logic low level is the maximum tolerable (negative) dV_{CM}/dt on the trailing edge of the common mode pulse signal, V_{CM} , to assure that the output will remain in a logic low state (i.e., $V_O < 0.8V$).

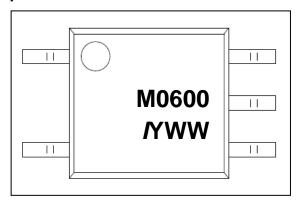


ORDER INFORMATION

ICPLM600, ICPLM601					
After PN	PN	Packing quantity			
None	ICPLM600, ICPLM601	Surface Mount Tape & Reel	3000 pcs per reel		

DEVICE MARKING

Example: ICPLM600



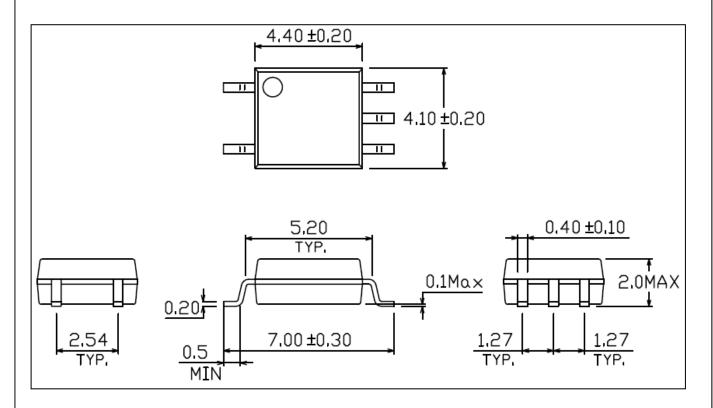
M0600 denotes Device Part Number

I denotes Isocom

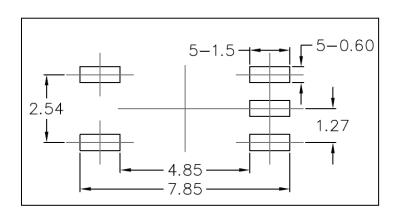
Y denotes 1 digit Year code WW denotes 2 digit Week code



PACKAGE DIMENSIONS (mm)

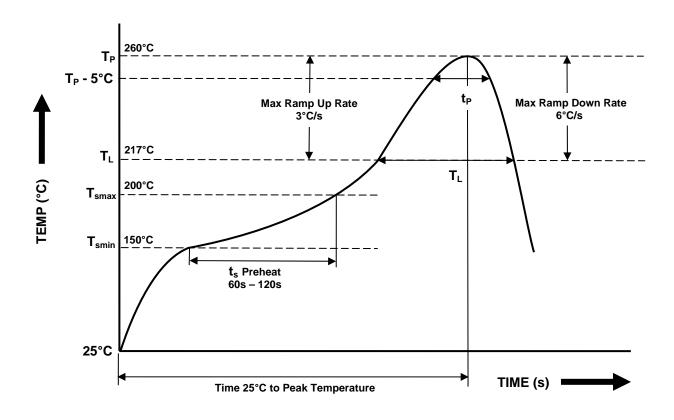


RECOMMENDED PAD LAYOUT (mm)





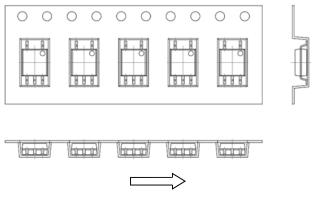
IR REFLOW SOLDERING TEMPERATURE PROFILE (One Time Reflow Soldering is Recommended)



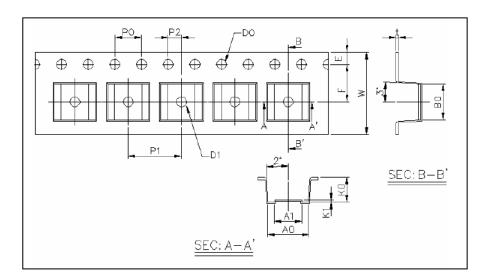
Profile Details	Conditions
Preheat - Min Temperature (T _{SMIN}) - Max Temperature (T _{SMAX}) - Time T _{SMIN} to T _{SMAX} (t _s)	150°C 200°C 60s - 120s
	260°C 217°C 30s 60s - 100s 3°C/s max 6°C/s max
Average Ramp Up Rate (T _{smax} to T _P)	3°C/s max
Time 25°C to Peak Temperature	8 minutes max



TAPE AND REEL PACKAGING



Direction of feed from reel



Dimension No.	Α0	A 1	В0	D0	D1	E	F
Dimension(mm)	6.2±0.1	4.1±0.1	7.4±0.1	1.5±0.1	1.5±0.1	1.75±0.1	5.5±0.1
Dimension No.	P0	P1	P2	t	w	K0	K1
Dimension (mm)	4.0±0.1	8.0±0.1	2.0±0.1	0.4±0.1	12.0 +0.3 / -0.1	3.7±0.1	0.3±0.1



NOTES:

- Isocom is continually improving the quality, reliability, function or design and Isocom reserves the right to make changes without further notices.
- The products shown in this publication are designed for the general use in electronic applications such as office automation equipment, communications devices, audio/visual equipment, electrical application and instrumentation.
- For equipment/application where high reliability or safety is required, such as space applications, nuclear power control equipment, medical equipment, etc., please contact our sales representatives.
- When requiring a device for any "specific" application, please contact our sales for advice.
- The contents described herein are subject to change without prior notice.
- Do not immerse device body in solder paste.



DISCLAIMER

ISOCOM is continually working to improve the quality and reliability of its products. Nevertheless, semiconductor devices in general can malfunction or fail due to their inherent electrical sensitivity and vulnerability to physical stress. It is the responsibility of the buyer, when utilizing ISOCOM products, to comply with the standards of safety in making a safe design for the entire system, and to avoid situations in which a malfunction or failure of such ISOCOM products could cause loss of human life, bodily injury or damage to property.

In developing your designs, please ensure that ISOCOM products are used within specified operating ranges as set forth in the most recent ISOCOM products specifications.

The ISOCOM products listed in this document are intended for usage in general electronics applications (computer, personal equipment, office equipment, measuring equipment, industrial robotics, domestic appliances, etc.). These ISOCOM products are neither intended nor warranted for usage in equipment that requires extraordinarily high quality and/or reliability or a malfunction or failure of which may cause loss of human life or bodily injury ("Unintended Usage"). Unintended Usage include atomic energy control instruments, airplane or spaceship instruments, transportation Instruments, traffic signal instruments, combustion control instruments, medical Instruments, all types of safety devices, etc.. Unintended Usage of ISOCOM products listed in this document shall be made at the customer's own risk.

Gallium arsenide (GaAs) is a substance used in the products described in this document.

__ Gallium arsenide (GaAs) is a substance used in the products described in this document. GaAs dust and fumes are toxic. Do not break, cut or pulverize the product, or use chemicals to dissolve them. When disposing of the products, follow the appropriate regulations. Do not dispose of the products with other industrial waste or with domestic garbage.

__ The products described in this document are subject to the foreign exchange and foreign trade laws.

___ The information contained herein is presented only as a guide for the applications of our products. No responsibility is assumed by ISOCOM Components for any infringements of intellectual property or other rights of the third parties which may result from its use. No license is granted by implication or otherwise under any intellectual property or other rights of ISOCOM Components or others.

The information contained herein is subject to change without notice.

X-ON Electronics

Largest Supplier of Electrical and Electronic Components

Click to view similar products for High Speed Optocouplers category:

Click to view products by Isocom manufacturer:

Other Similar products are found below:

6N136F HCPL-2201-300 JAN4N24 610737H HCPL2630M HCPL2630SM PS9817A-1-F3-AX PS9821-2-F3-AX TLP2766A(E TLP2766A(LF4,E PS9121-F3-AX TLP5774H(TP4,E TLP5771H(TP,E TLP2304(E(O 054279X HCPL2631SD HCPL-2730-500E TLP118(TPL,E) TLP2309(E(T TLP2366(TPL,E TLP2368(TPL,E(T TLP521-2XGB TLP621-2XGB JANTXV4N24U 8102802PC 5962-8767902XA 5962-8876801XA 5962-8957101PA SFH6318T 6N135-300E TIL198 TLP104(TPR,E) TLP2309(TPL,E) TLP2355(TPL,E TLP2358(E) TLP521-4GR TLP521-4XGB TLP621XSM 5962-8876801PA IS281-4GB IS2805-4 IS181GR ICPL2630 ICPL2531 ICPL2601 ICPL2530 5962-8876801PC TLP2301 TLP2301(E(T TLP2362(TPR,E